**ON Semiconductor** 

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# on semiconductor® FDS4559

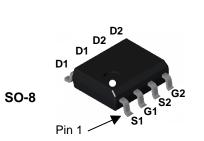
## 60V Complementary PowerTrench®MOSFET

#### **General Description**

This complementary MOSFET device is produced using ON Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

#### Applications

- DC/DC converter
- Power management
- LCD backlight inverter



#### Features

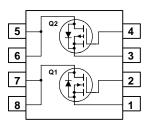
#### Q1: N-Channel

4.5 A, 60 V  $R_{DS(on)} = 55 \text{ m}\Omega @ V_{GS} = 10V$  $R_{DS(on)} = 75 \text{ m}\Omega @ V_{GS} = 4.5V$ 

• Q2: P-Channel

$$-3.5 \text{ A}, -60 \text{ V} \text{ R}_{\text{DS(on)}} = 105 \text{ m}\Omega \text{ @ V}_{\text{GS}} = -10 \text{ V}$$

 $R_{DS(on)} = 135 \text{ m}\Omega @ V_{GS} = -4.5 \text{V}$ 



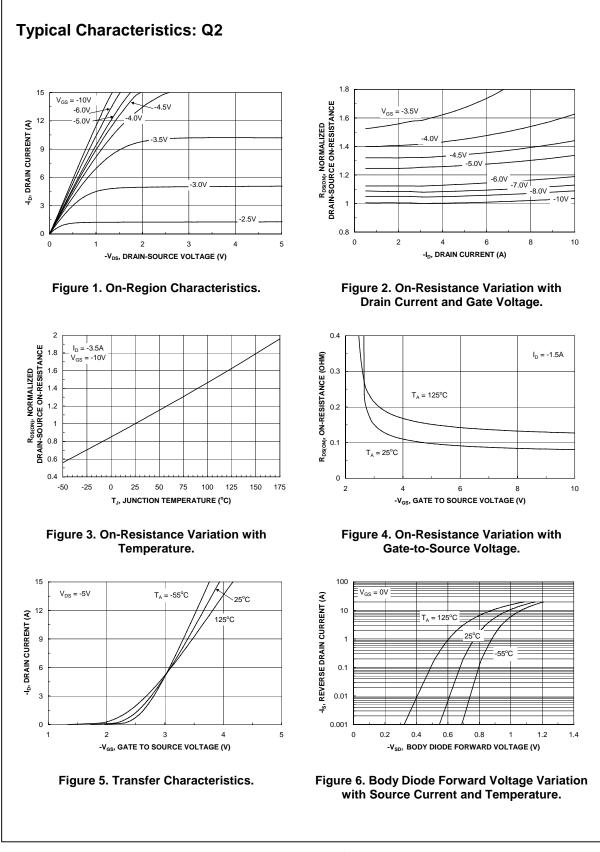
### Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

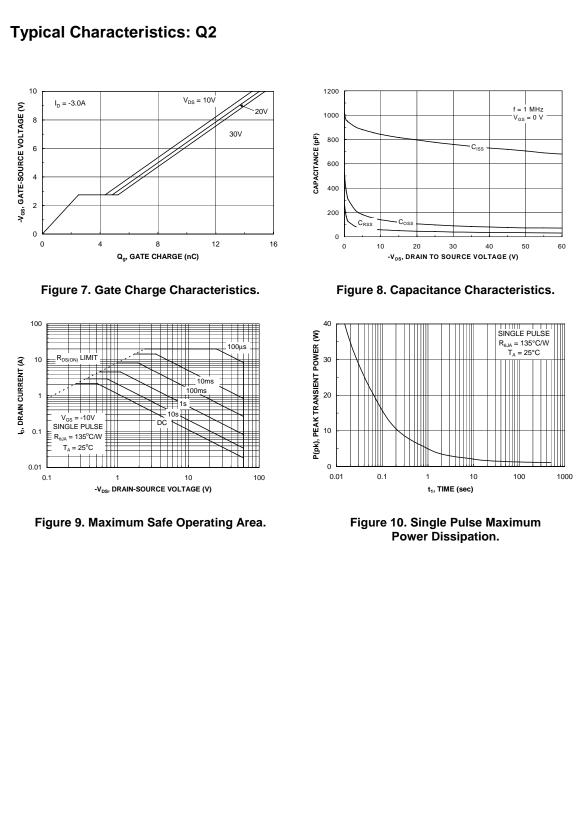
Symbol	Parameter			Q1	Q2	Units	
V <sub>DSS</sub>	Drain-Source	Drain-Source Voltage			-60	V	
V <sub>GSS</sub>	Gate-Source Voltage			±20	±20	V	
ID	Drain Current - Continuous (Note 1a) 4.5				-3.5	.5 A	
		- Pulsed		20	-20		
P <sub>D</sub>	Power Dissipation for Dual Operation			2		W	
	Power Dissipation for Single Operation (Note 1a)			1.6			
	(Note 1b)			1.2			
			(Note 1c)		1		
T <sub>J</sub> , T <sub>STG</sub>	Operating an	nd Storage Junction Tempe	rature Range	-55 to	°C		
Therma	I Charact	eristics					
R <sub>0JA</sub>	Thermal Res	hermal Resistance, Junction-to-Ambient		78		°C/W	
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case		(Note 1)	40		°C/W	
Packag	e Marking	g and Ordering In	formation				
Device Marking		Device	Reel Size	Tape wi	vidth Quan		
FDS4559		FDS4559	13"	12mm	12mm		

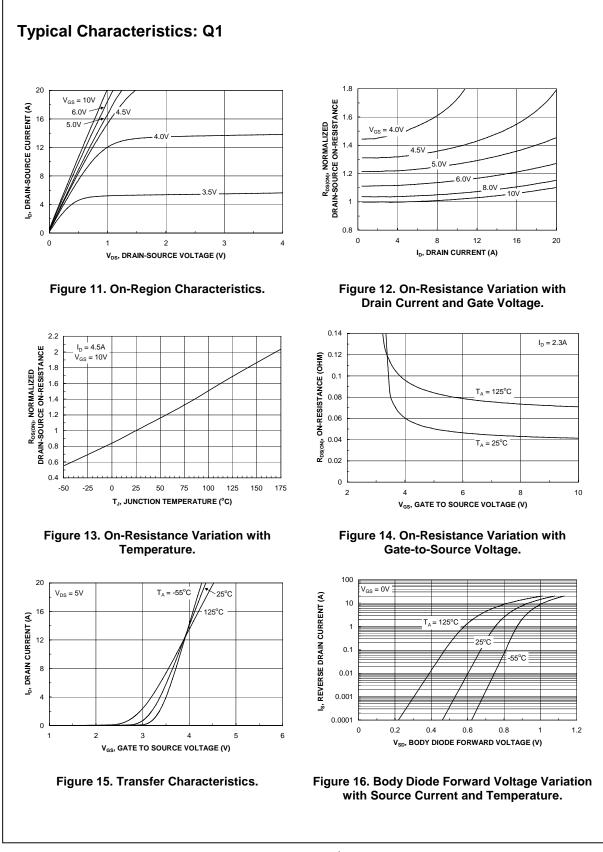
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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-So	ource Avalanche Ratin	QS (Note 1)				•	•
W <sub>DSS</sub>	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 30 \text{ V}, \qquad I_D = 4.5 \text{ A}$	Q1			90	mJ
I <sub>AR</sub>	Maximum Drain-Source Avalanche Current		Q1			4.5	A
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	Q1	60			V
	Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	Q2	-60			
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C $I_D = -250 \ \mu$ A, Referenced to 25°C	Q1 Q2		58 49		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 48 V, V_{GS} = 0 V$ $V_{DS} = -48 V, V_{GS} = 0 V$	Q1 Q2			1 -1	μA
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	Q1			<u>+</u> 100	nA
		$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	Q2			<u>+</u> 100	
	racteristics (Note 2)						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$ $V_{DS} = V_{GS}, I_D = -250 \ \mu A$	Q1 Q2	1 –1	2.2 -1.6	3 _3	V
$\Delta V_{GS(th)}$	Gate Threshold Voltage	$I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ C	Q1		-5.5		mV/°C
$\Delta T_{J}$	Temperature Coefficient	$I_D = -250 \mu$ A, Referenced to $25^{\circ}$ C	Q2		4		
	Static Drain-Source	$V_{GS} = 10 \text{ V}, I_D = 4.5 \text{ A}$	Q1		42	55	mΩ
	On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 4.5 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 4 \text{ A}$			72 55	94 75	
		$V_{GS} = -10 \text{ V}, \text{ I}_D = -3.5 \text{ A}$	Q2		82	105	-
		$V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}, T_J = 125^{\circ}\text{C}$	~-		130	190	
		$V_{GS} = -4.5 \text{ V}, I_D = -3.1 \text{ A}$	<b>.</b> .		105	135	L .
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ $V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	Q1 Q2	20 –20			A
<b>g</b> fs	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_D = 4.5 \text{ A}$ $V_{DS} = -5 \text{ V}, I_D = -3 5 \text{ A}$	Q1 Q2		14 9		S
Dynami	a Characteristics		Q,L		Ŭ		
	c Characteristics	Q1	Q1		650		pF
Uiss	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	Q2		759		pr
Coss	Output Capacitance	f = 1.0 MHz	Q1		80		pF
<u> </u>	Reverse Transfer	Q2 $V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$	Q2		90		~ <b>Г</b>
C <sub>rss</sub>	Capacitance	f = 1.0  MHz	Q1 Q2		35 39		pF
			~-				
	g Characteristics (Note :				44	20	
d(on)	Turn-On Delay Time	Q1 V <sub>DD</sub> = 30 V, I <sub>D</sub> = 1 A,	Q1 Q2		11 7	20 14	ns
r	Turn-On Rise Time	$V_{GS} = 10V, R_{GEN} = 6 \Omega$	Q1		8	18	ns
	Turn Off Dalay Time		Q2		10	20	
d(off)	Turn-Off Delay Time	Q2 $V_{DD} = -30 \text{ V}, \text{ I}_{D} = -1 \text{ A},$	Q1 Q2		19 19	35 34	ns
f	Turn-Off Fall Time	$V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1		6	15	ns
<b>J</b> g	Total Gate Charge	Q1	Q2 Q1		12 12.5	22 18	nC
	Gate-Source Charge	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 4.5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$	Q2 Q1		15 2.4	21	nC
λ <sub>gs</sub>	Cale-Source Clidige	Q2	Q1 Q2		2.4 2.5		
λ <sub>gd</sub>	Gate-Drain Charge	$V_{DS} = -30 \text{ V}, \text{ I}_{D} = -3.5 \text{ A}, \text{ V}_{GS} = -10 \text{ V}$	Q1		2.6		nC
			Q2		3.0		

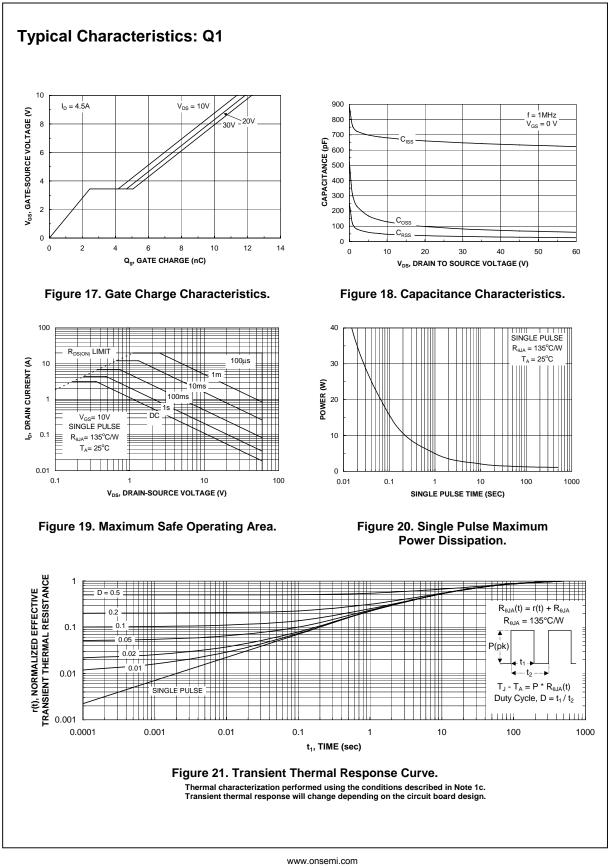
#### Electrical Characteristics (continued) $T_A = 25^{\circ}C$ unless otherwise noted Symbol Parameter **Test Conditions** Туре Min Тур Max Units **Drain-Source Diode Characteristics and Maximum Ratings** Maximum Continuous Drain-Source Diode Forward Current ls Q1 1.3 А Q2 -1.3 $\begin{array}{l} \mbox{Drain-Source Diode Forward} \\ \mbox{Voltage} \end{array} \begin{array}{l} \mbox{V}_{GS} = 0 \ V, \ I_S = 1.3 \ A \quad (Note \ 2) \\ \mbox{V}_{GS} = 0 \ V, \ I_S = -1.3 \ A \quad (Note \ 2) \end{array}$ $V_{\text{SD}}$ Q1 0.8 1.2 V Q2 -1.2 -0.8 Notes: 1. R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\rm R_{\theta JC}$ is guaranteed by design while $\rm R_{\theta CA}$ is determined by the user's board design. Q Q Q D b) 125°C/W when mounted on a .02 in<sup>2</sup> pad of 2 oz copper a) 78°C/W when c) 135°C/W when mounted on a mounted on a 0.5 in<sup>2</sup> pad of 2 oz copper minimum pad. 0690 Scale 1:1 on letter size paper 2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%







FDS4559



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